

Features

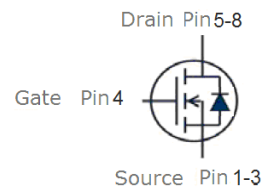
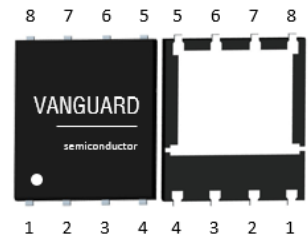
- Enhancement mode
- Low on-resistance $R_{DS(on)}$ @ $V_{GS}=4.5\text{ V}$
- VitoMOS[®] II Technology
- 100% Avalanche test
- Pb-free lead plating; RoHS compliant



Part ID	Package Type	Marking	Tape and reel information
VSP007N10MS-G	PDFN5x6	007N10M	3000PCS/Reel

V_{DS}	100	V
$R_{DS(on),TYP}@ V_{GS}=10\text{ V}$	5.7	m Ω
$R_{DS(on),TYP}@ V_{GS}=4.5\text{ V}$	7.5	m Ω
I_D	85	A

PDFN5x6



Maximum ratings, at $T_A = 25^\circ\text{C}$, unless otherwise specified

Symbol	Parameter	Rating	Unit
$V_{(BR)DSS}$	Drain-Source breakdown voltage	100	V
V_{GS}	Gate-Source voltage	± 20	V
I_S	Diode continuous forward current	$T_C = 25^\circ\text{C}$	85 A
I_D	Continuous drain current @ $V_{GS}=10\text{V}$	$T_C = 25^\circ\text{C}$	85 A
		$T_C = 100^\circ\text{C}$	54 A
I_{DM}	Pulse drain current tested ①	$T_C = 25^\circ\text{C}$	340 A
I_{DSM}	Continuous drain current @ $V_{GS}=10\text{V}$	$T_A = 25^\circ\text{C}$	21 A
		$T_A = 70^\circ\text{C}$	17 A
EAS	Avalanche energy, single pulsed ②	56	mJ
P_D	Maximum power dissipation	$T_C = 25^\circ\text{C}$	69 W
P_{DSM}	Maximum power dissipation ③	$T_A = 25^\circ\text{C}$	4.2 W
T_{STG}, T_J	Storage and Junction Temperature Range	-55 to 150	$^\circ\text{C}$

Thermal Characteristics

Symbol	Parameter	Typical	Unit
$R_{\theta JC}$	Thermal Resistance, Junction-to-Case	1.8	$^\circ\text{C/W}$
$R_{\theta JA}$	Thermal Resistance, Junction-to-Ambient	30	$^\circ\text{C/W}$

Electrical Characteristics

Symbol	Parameter	Condition	Min.	Typ.	Max.	Unit
Static Electrical Characteristics @ $T_j=25^\circ\text{C}$ (unless otherwise stated)						
$V_{(BR)DSS}$	Drain-Source Breakdown Voltage	$V_{GS}=0V, I_D=250\mu A$	100	--	--	V
I_{DSS}	Zero Gate Voltage Drain Current	$V_{DS}=100V, V_{GS}=0V$	--	--	1	μA
	Zero Gate Voltage Drain Current($T_j=125^\circ\text{C}$)	$V_{DS}=100V, V_{GS}=0V$	--	--	100	μA
I_{GSS}	Gate-Body Leakage Current	$V_{GS}=\pm 20V, V_{DS}=0V$	--	--	± 100	nA
$V_{GS(TH)}$	Gate Threshold Voltage	$V_{DS}=V_{GS}, I_D=250\mu A$	1.5	1.9	2.5	V
$R_{DS(ON)}$	Drain-Source On-State Resistance④	$V_{GS}=10V, I_D=20A$	--	5.7	8	m Ω
		$T_j=100^\circ\text{C}$	--	7.5	--	m Ω
$R_{DS(ON)}$	Drain-Source On-State Resistance④	$V_{GS}=4.5V, I_D=15A$	--	7.5	11	m Ω
Dynamic Electrical Characteristics @ $T_j = 25^\circ\text{C}$ (unless otherwise stated)						
C_{iss}	Input Capacitance	$V_{DS}=30V, V_{GS}=0V,$ $f=1\text{MHz}$	2275	2680	3080	pF
C_{oss}	Output Capacitance		865	1020	1175	pF
C_{riss}	Reverse Transfer Capacitance		25	35	45	pF
R_g	Gate Resistance	$f=1\text{MHz}$	--	1.3	--	Ω
$Q_g(10V)$	Total Gate Charge	$V_{DS}=50V, I_D=20A,$ $V_{GS}=10V$	--	40	--	nC
$Q_g(4.5V)$	Total Gate Charge		--	20	--	nC
Q_{gs}	Gate-Source Charge		--	9.3	--	nC
Q_{gd}	Gate-Drain Charge		--	6.2	--	nC
Switching Characteristics						
$t_{d(on)}$	Turn-on Delay Time	$V_{DD}=50V,$ $I_D=20A,$ $R_G=3\Omega,$ $V_{GS}=10V$	--	10.5	--	ns
t_r	Turn-on Rise Time		--	19	--	ns
$t_{d(off)}$	Turn-Off Delay Time		--	30	--	ns
t_f	Turn-Off Fall Time		--	11	--	ns
Source- Drain Diode Characteristics @ $T_j = 25^\circ\text{C}$ (unless otherwise stated)						
V_{SD}	Forward on voltage	$I_{SD}=20A, V_{GS}=0V$	--	0.8	1.2	V
t_{rr}	Reverse Recovery Time	$T_j=25^\circ\text{C}, I_{sd}=20A,$ $V_{GS}=0V$ $di/dt=100A/\mu s$	--	46	--	ns
Q_{rr}	Reverse Recovery Charge		--	53	--	nC

NOTE: ① Repetitive rating; pulse width limited by max junction temperature.

② Limited by T_{jmax} , starting $T_j = 25^\circ\text{C}$, $L = 0.5\text{mH}$, $R_G = 25\Omega$, $I_{AS} = 15A$, $V_{GS} = 10V$. Part not recommended for use above this value

③ The power dissipation P_{DSM} is based on $R_{\theta JA}$ and the maximum allowed junction temperature of 150°C .

④ Pulse width $\leq 380\mu s$; duty cycles $\leq 2\%$.

Typical Characteristics

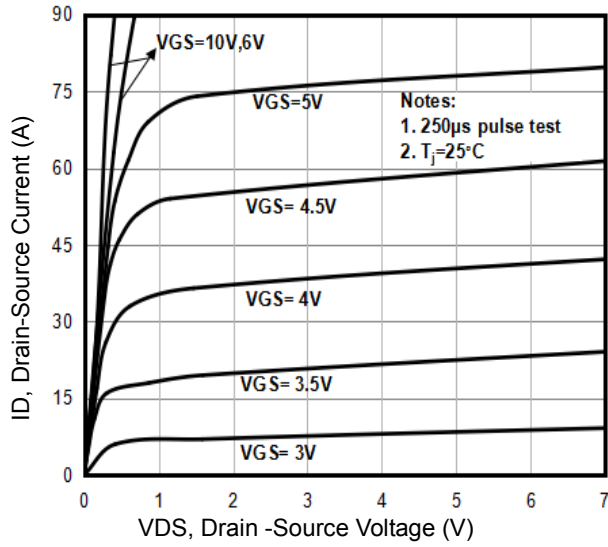


Fig1. Typical Output Characteristics

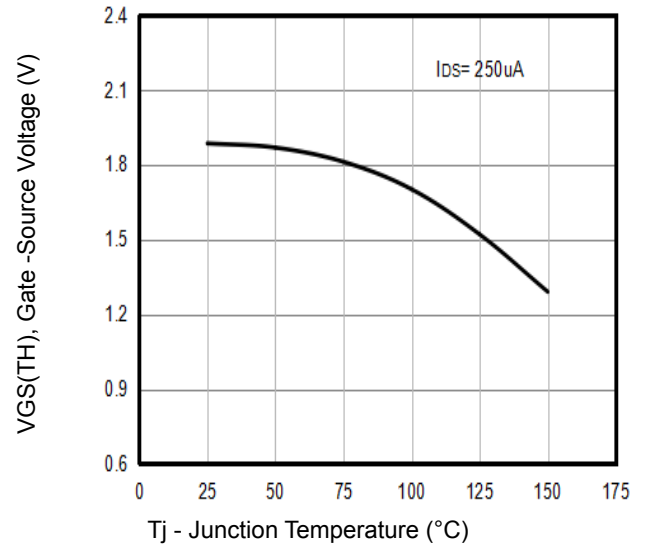


Fig2. $V_{GS(TH)}$ Gate-Source Voltage Vs. T_j

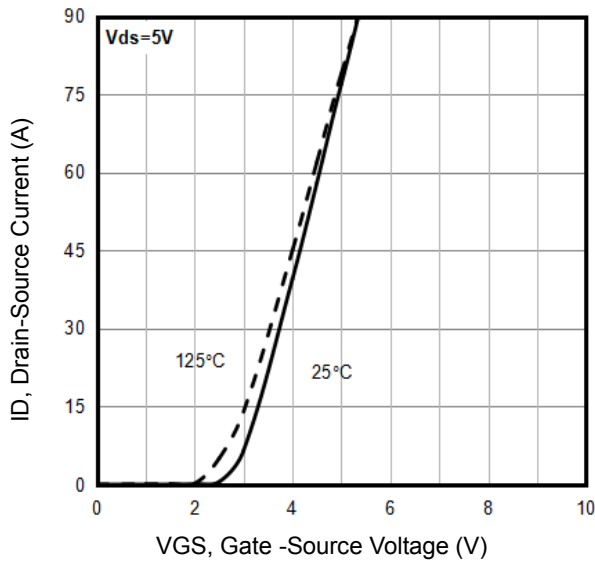


Fig3. Typical Transfer Characteristics

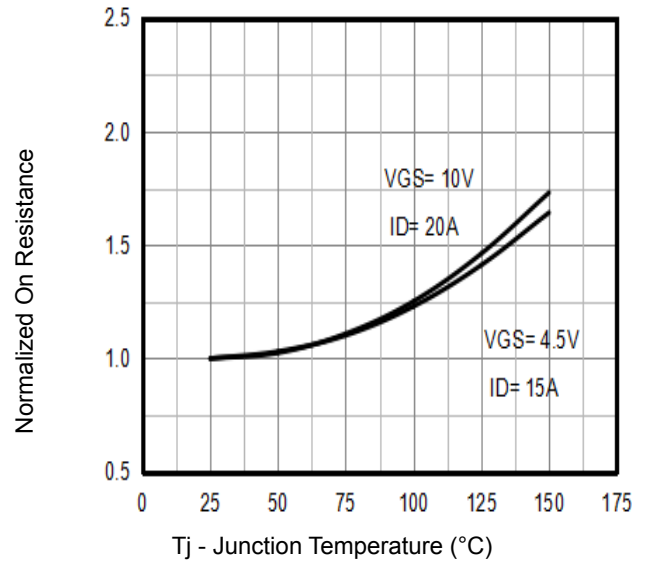


Fig4. Normalized On-Resistance Vs. T_j

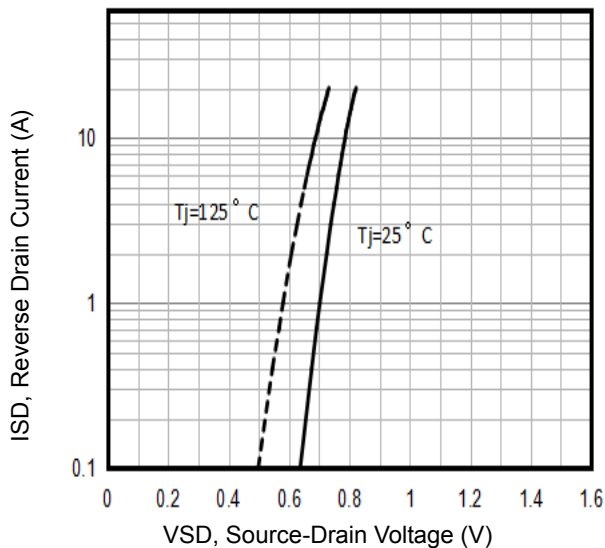


Fig5. Typical Source-Drain Diode Forward Voltage

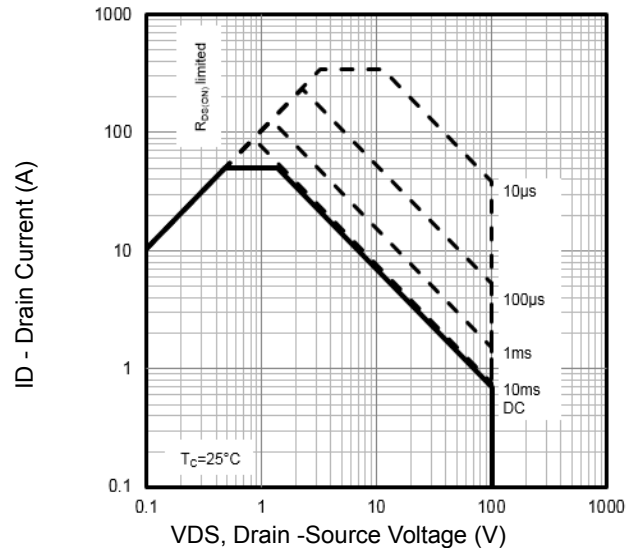


Fig6. Maximum Safe Operating Area

Typical Characteristics

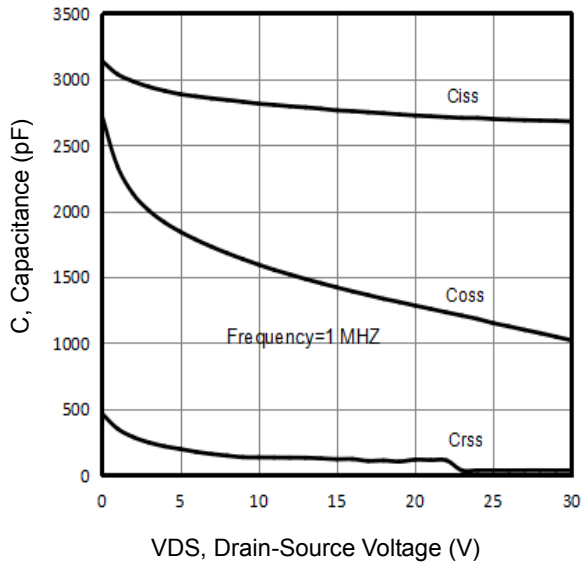


Fig7. Typical Capacitance Vs. Drain-Source Voltage

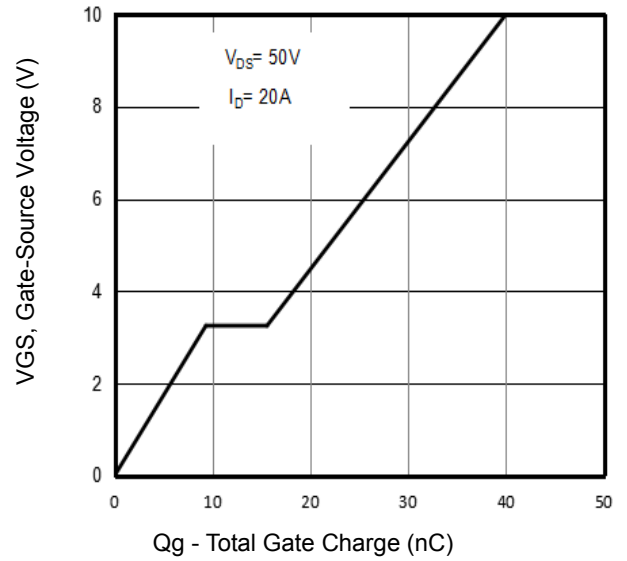


Fig8. Typical Gate Charge Vs. Gate-Source Voltage

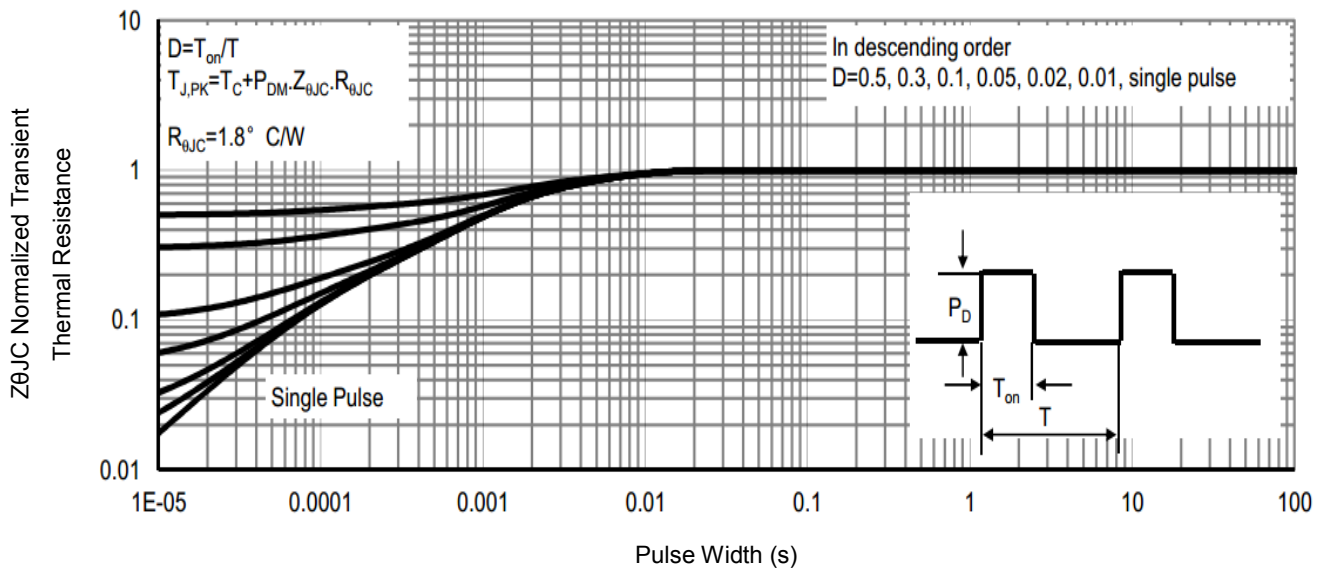


Fig9. Normalized Maximum Transient Thermal Impedance

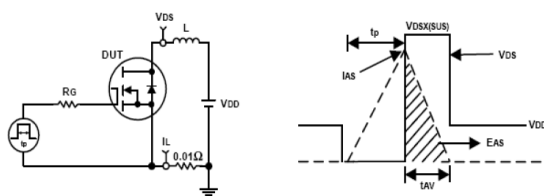


Fig10. Unclamped Inductive Test Circuit and waveforms

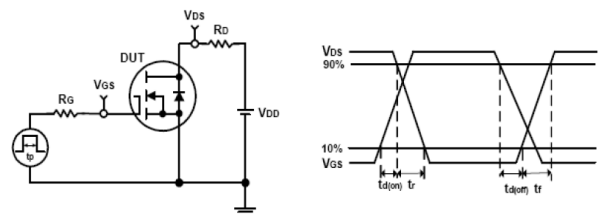
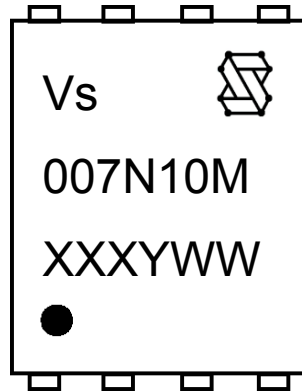


Fig11. Switching Time Test Circuit and waveforms

Marking Information



1st line: Vanguard Code (Vs), Vanguard Logo

2nd line: Part Number (007N10M)

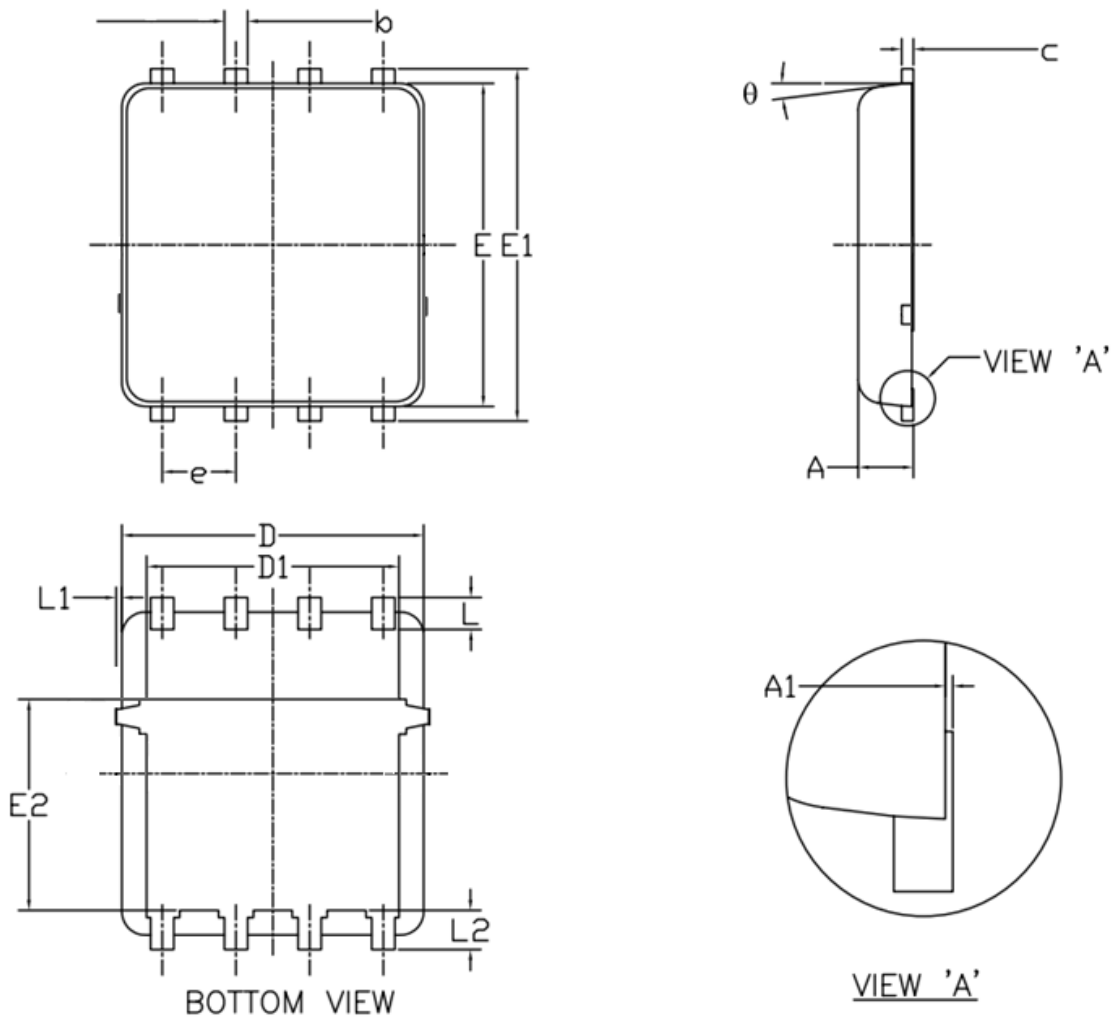
3rd line: Date code (XXXYYWW)

XXX: Wafer Lot Number Code , code changed with Lot Number

Y: Year Code, (e.g. E=2017, F=2018, G=2019, H=2020, etc)

WW: Week Code (01 to 53)

PDFN5x6 Package Outline Data



Symbol	DIMENSIONS (unit : mm)		
	Min	Typ	Max
A	0.90	1.00	1.20
A1	0.00	--	0.05
b	0.30	0.40	0.51
c	0.20	0.25	0.33
D	4.80	4.90	5.40
D1	3.61	4.00	4.25
E	5.65	5.80	6.06
E1	5.90	6.10	6.35
E2	3.38	3.58	3.92
e	1.27 BSC		
L	0.51	0.61	0.71
L1	--	--	0.15
L2	0.41	0.51	0.61
θ	0°	--	12°

Notes:

1. Refer to JEDEC MO-240 variation AA.
2. Dimensions "D" and "E" do NOT include mold flash protrusions or gate burrs.
3. Dimensions "D" and "E" include interterminal flash or protrusion. Interterminal flash or protrusion shall not exceed 0.25mm per side.

Customer Service

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